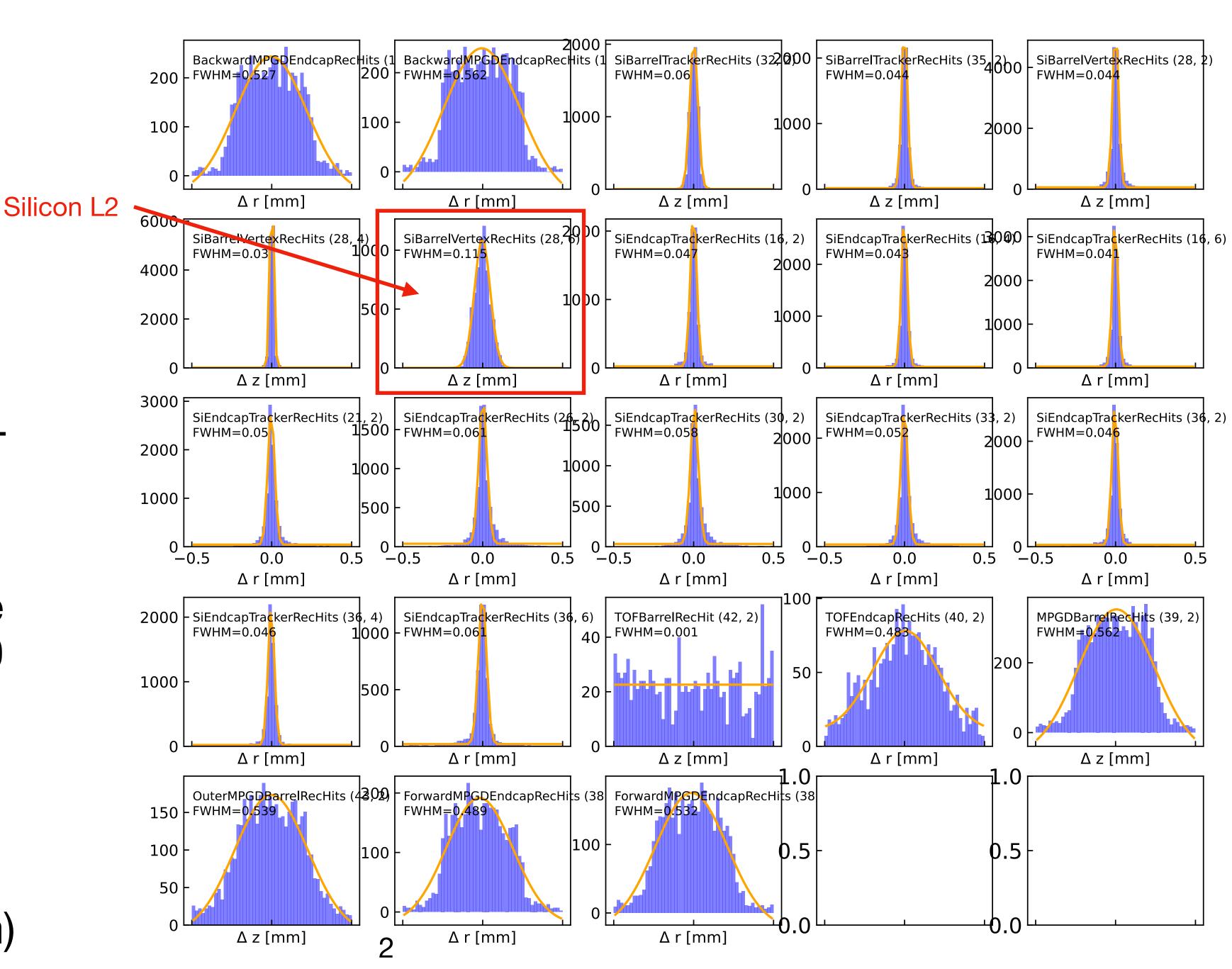
EIC Residuals

EIC LBL meeting updates 20 February 2024

Residuals

Reminder: Residuals in different layers

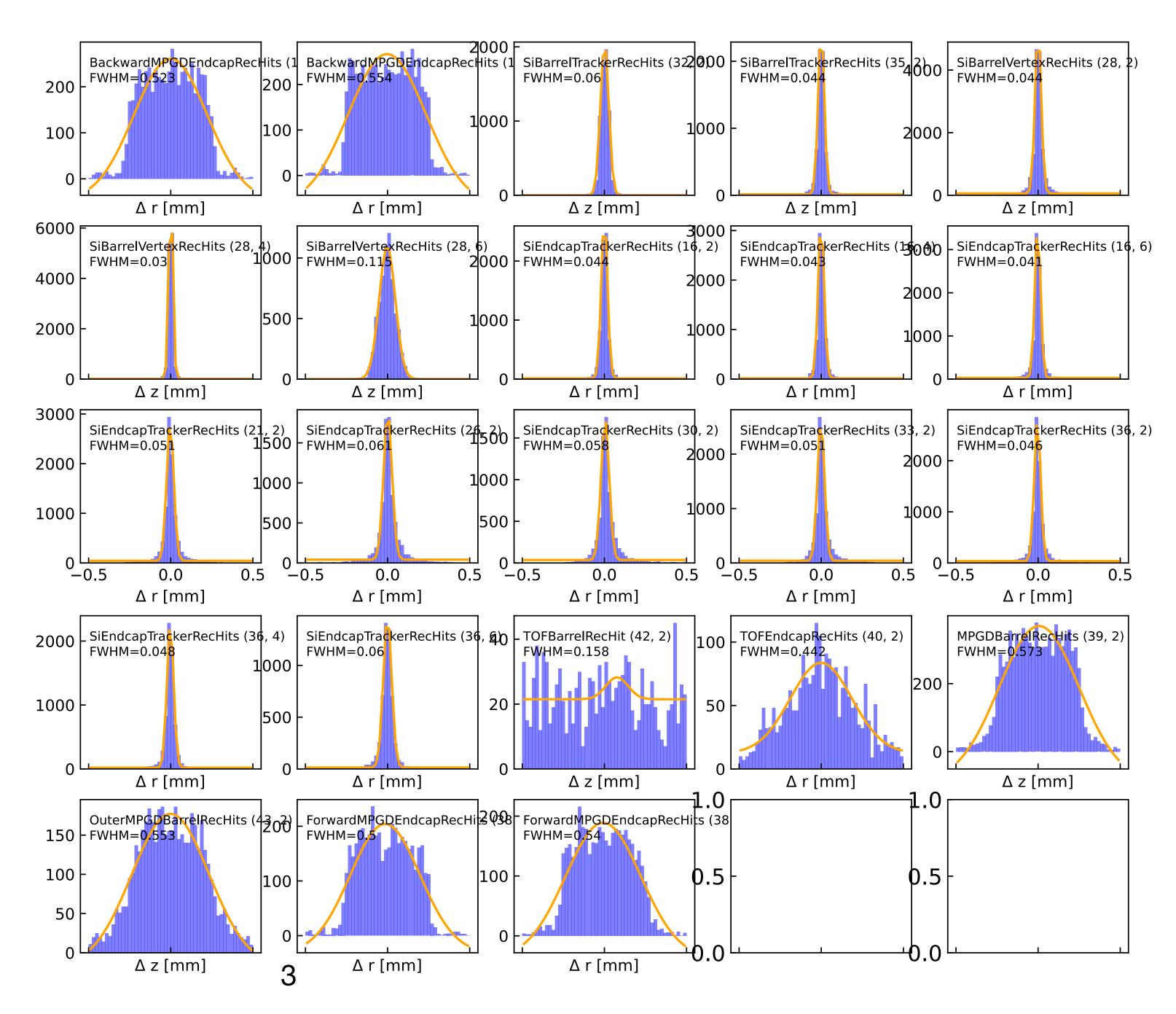
- Realistic seeded, μ-
- 0.5 < p < 20 GeV/c
- Silicon peaks range from a FWHM of 30
 - 115µm
 - (compared to truth seeded: FWHM ranges from 24 - 125 µm)



Using a new material map

- Material map made by Shujie
- Slight differences in the residuals, but mostly hard to notice

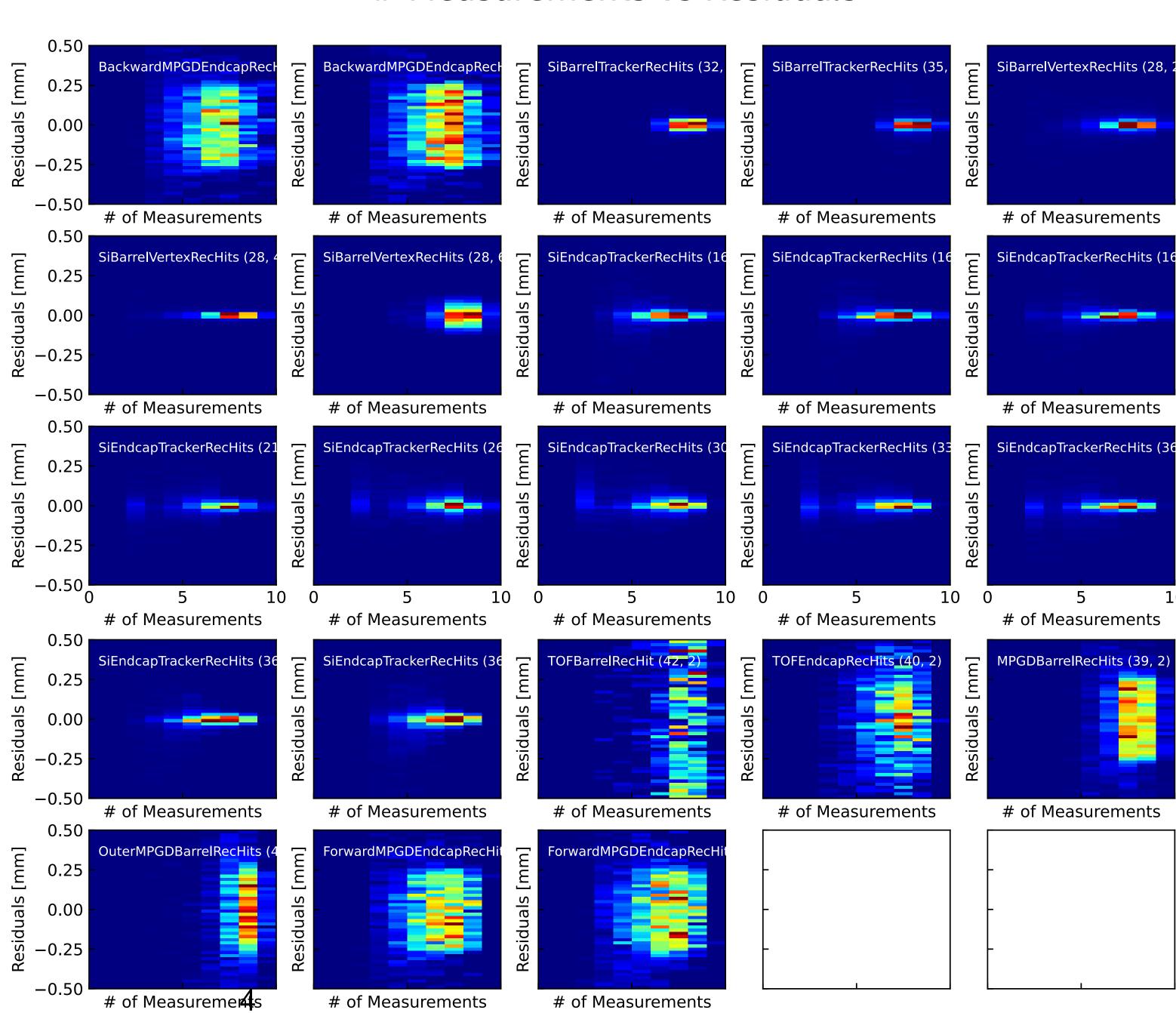
Residuals



Measurements vs Residuals

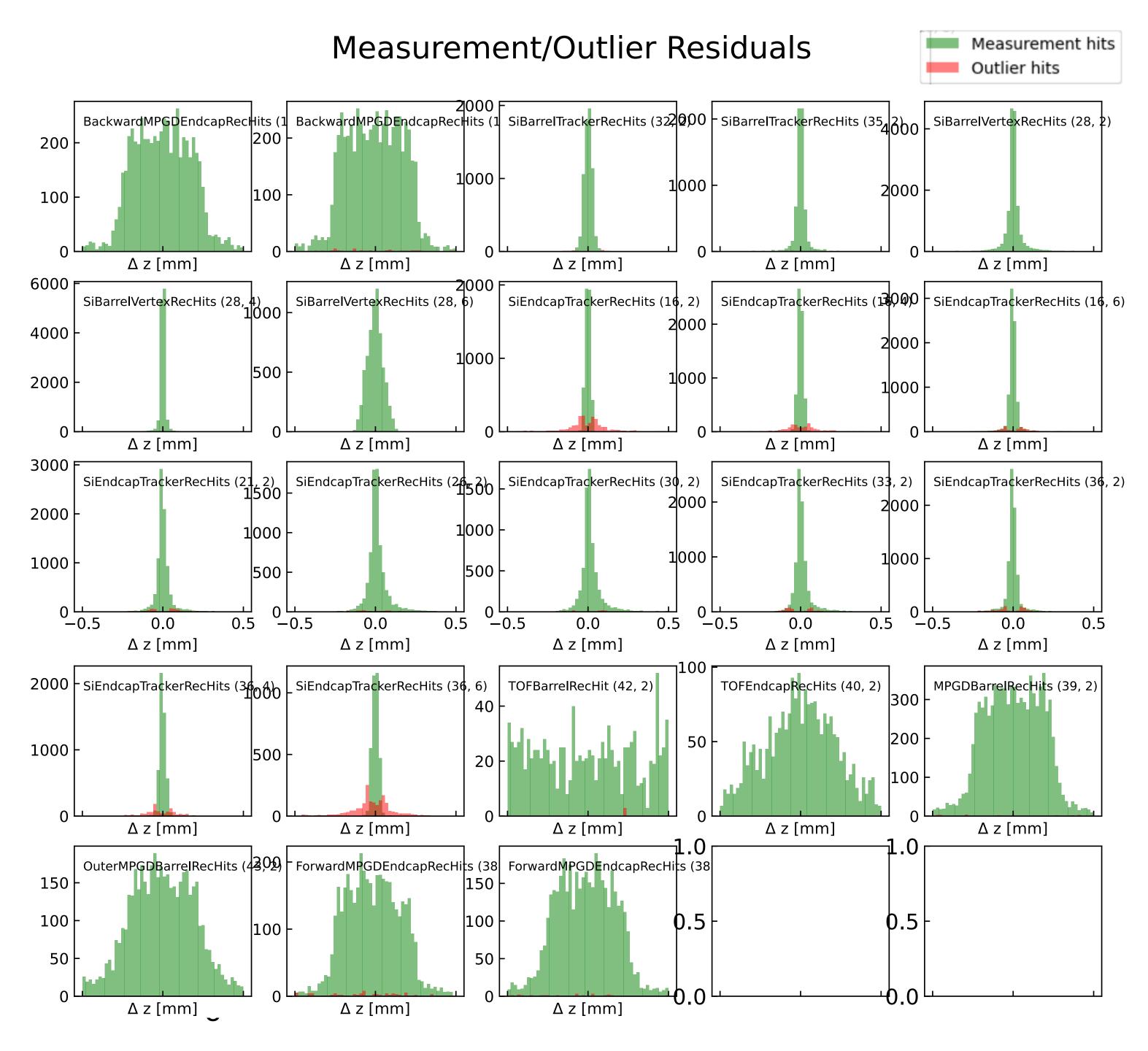
Looking at the # of measurements

- # of measurements vs residuals
- residuals is a hit quantity, # of meas is a track quantity
- mostly 6-8 hits per track



Measurement vs outlier hits

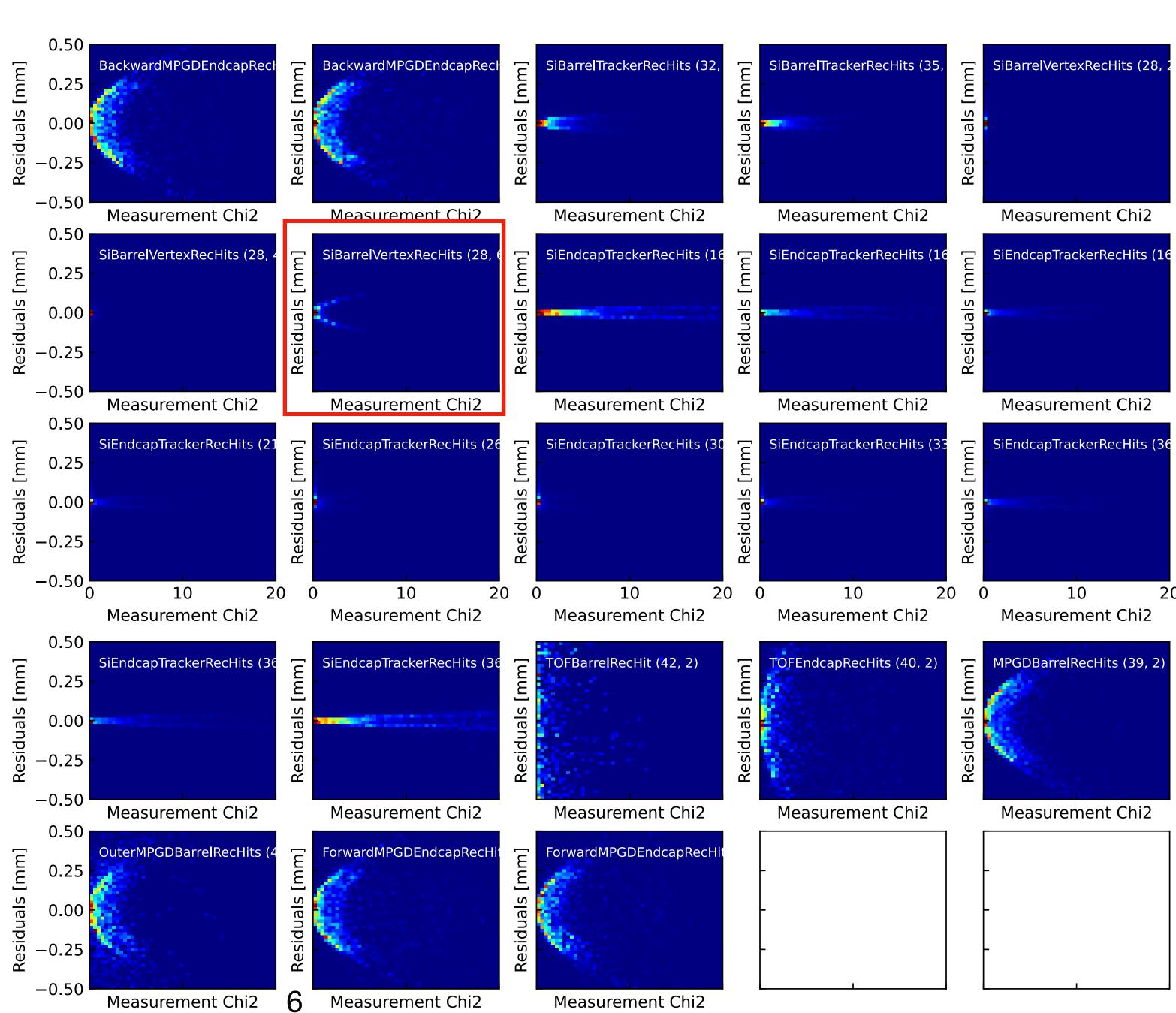
 Wanted to see which hits were used in the final track fit



Measurement Chi2 vs Residuals

Measurement Chi^2

 See some sort of correlation between measurement chi^2 and the residual in silicon L2



TOF Barrel layer

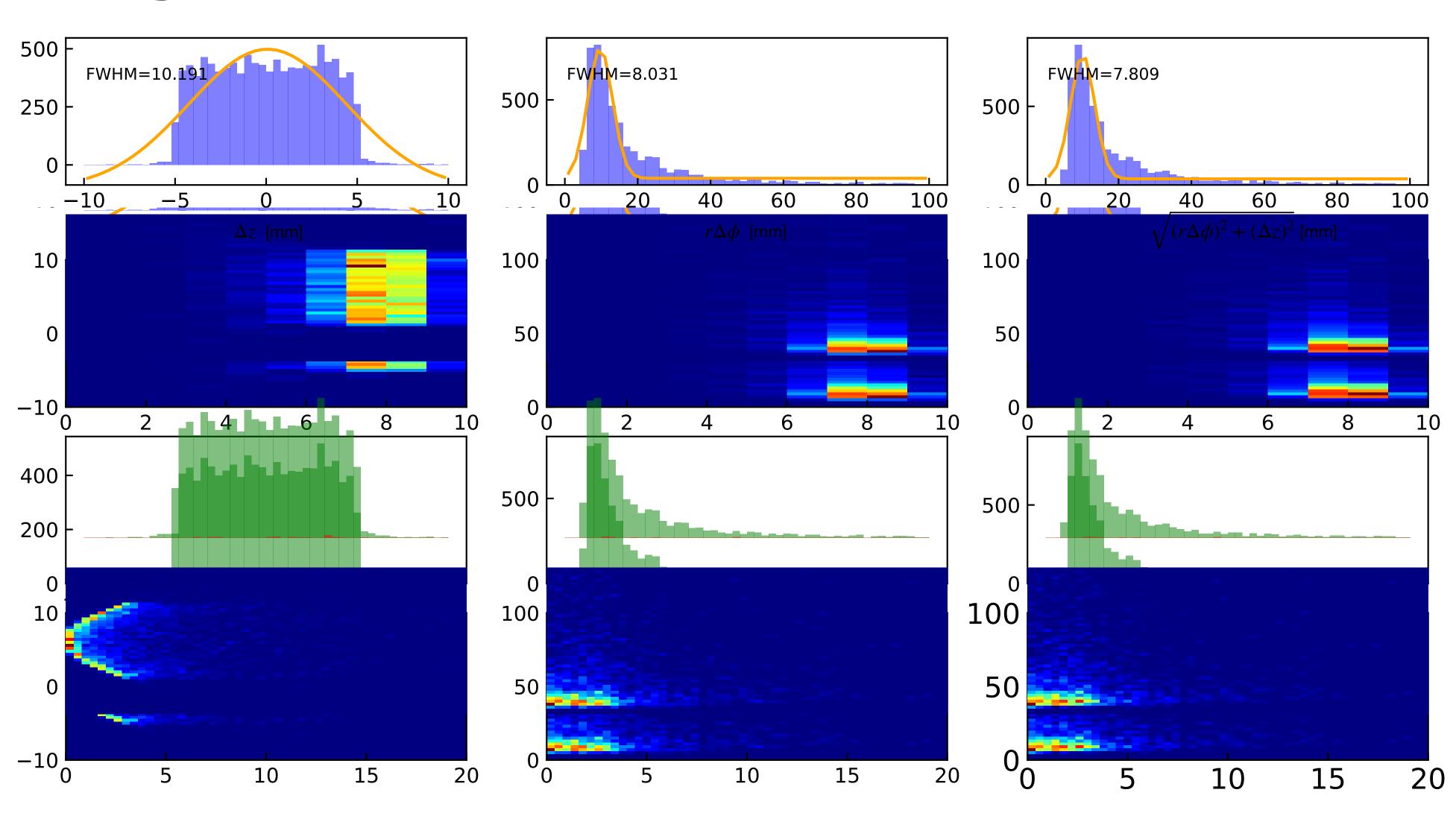
TOF Barrel Layer

Residuals [mm]:

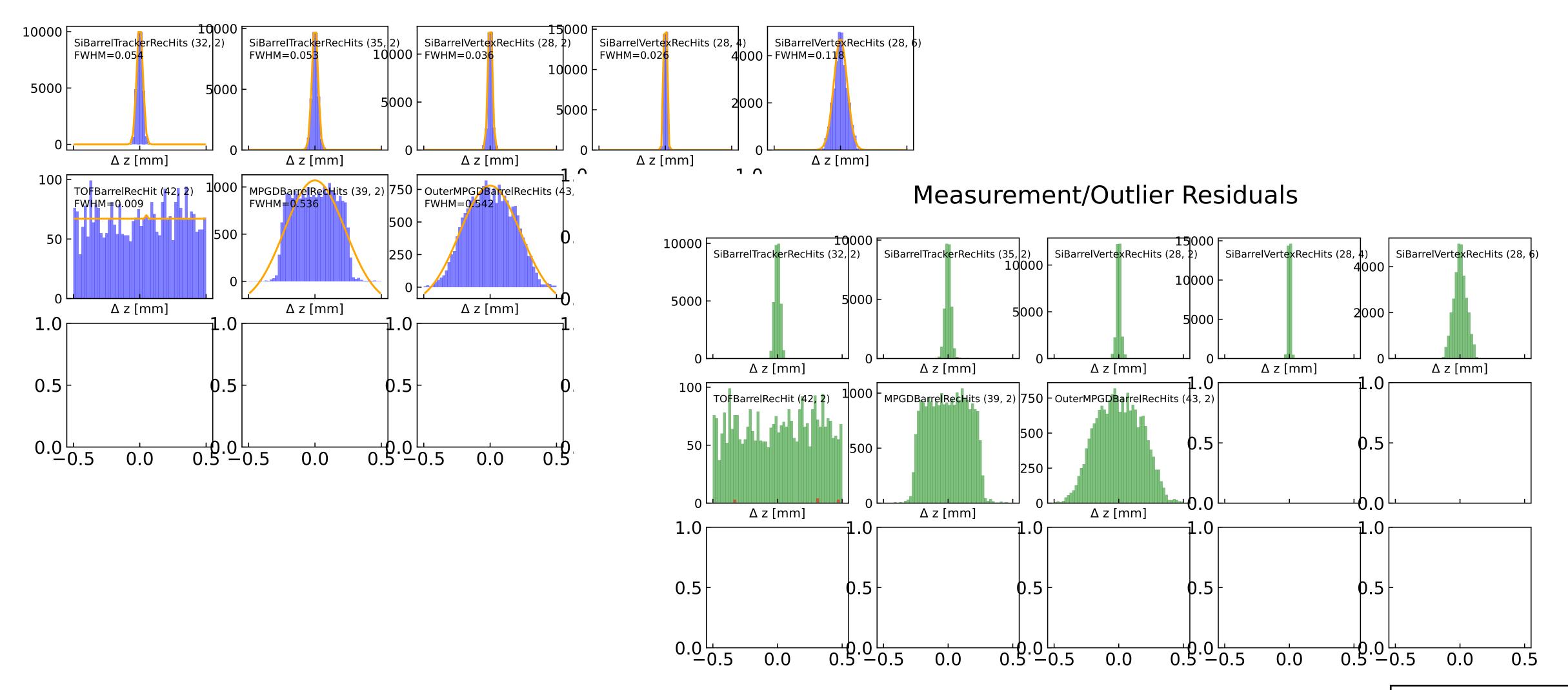
Residuals [mm] vs # of measurements:

Residuals [mm] for measurements vs outliers:

Residuals [mm] vs measurements chi2:



90 degree muons Residuals

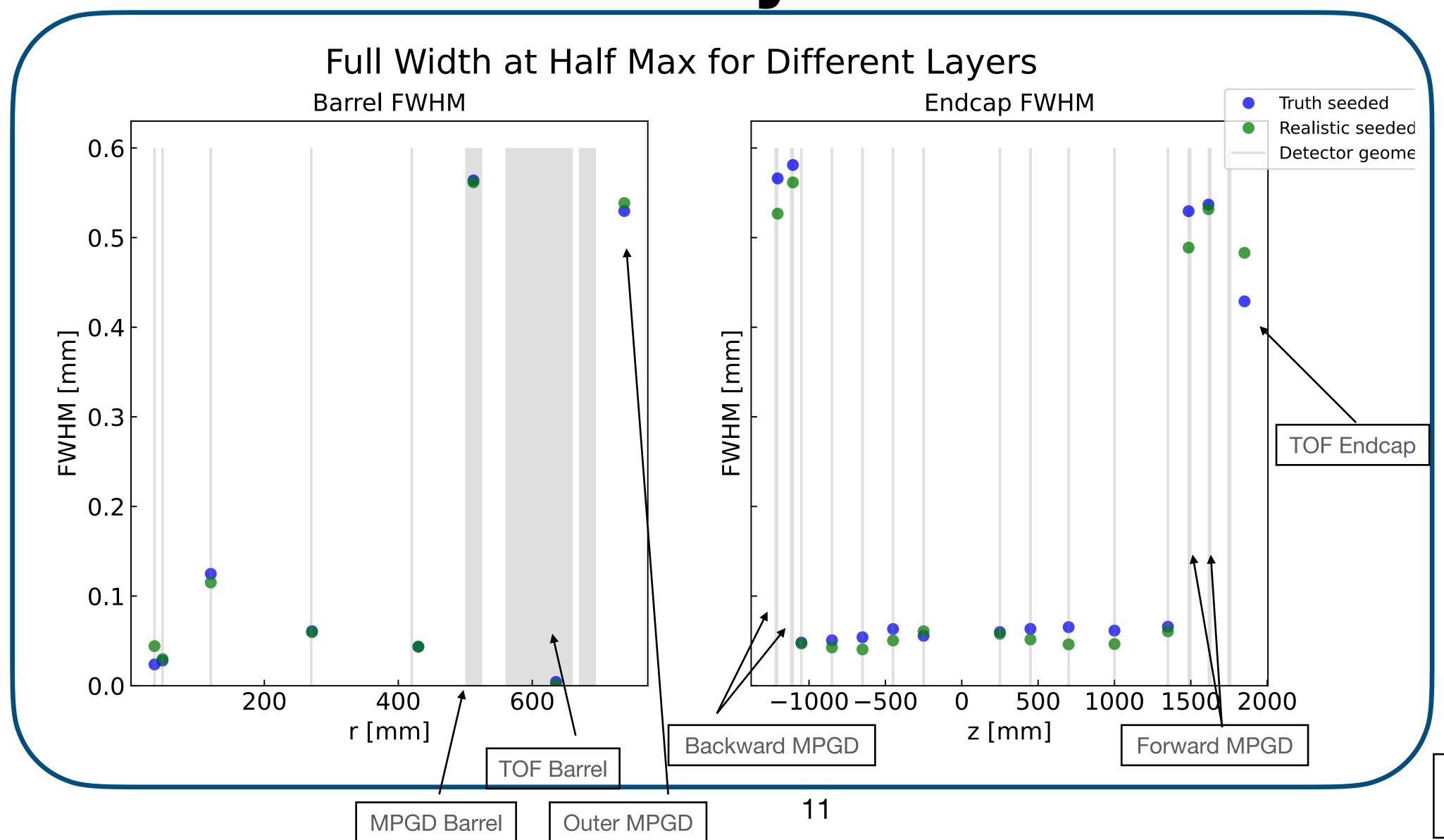


Summary and Next Steps

- Studied some of the correlations between the measurements and the residuals
- Silicon L2 residual does not change with the new material map, or a selection of muons at 90 degrees
- Make unbiased residuals
 - Some functionality in ACTS to do this:
 - https://github.com/acts-project/acts/commit/c21fc44fbe914473e13880da58798f13dfd542a5
- Run all residuals with DIS events

FWHM at different layers

*See different TOF endcap coordinates at: https://eic.jlab.org/ Geometry/Detector/Detector-20231031150001.html



Single µ-, full reconstruction

Example of a track

- Reconstructed hits
 - Plotted are both "measurementHits" and "outlierHits"
- Track segment points = the points on a track at each surface
 - Includes calibrated+uncalibrated states

